# MOSFET – Power, Single N-Channel 60 V, 2.5 mΩ, 155 A

## **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V <sub>DSS</sub>	60	V	
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	155	Α
rent R <sub>θJC</sub> (Notes 1 & 3)		T <sub>C</sub> = 100°C		110	
Power Dissipation R <sub>θJC</sub>		T <sub>C</sub> = 25°C	$P_{D}$	115	W
(Note 1)		T <sub>C</sub> = 100°C		58	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	29	Α
Current R <sub>θJA</sub> (Notes 1, 2 & 3)		T <sub>A</sub> = 100°C		21	
Power Dissipation $R_{\theta JA}$		T <sub>A</sub> = 25°C	$P_{D}$	4	W
(Notes 1 & 2)		T <sub>A</sub> = 100°C		2	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C	
Source Current (Body Diode)		I <sub>S</sub>	96	Α	
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, I <sub>L(pk)</sub> = 14.4 A)		E <sub>AS</sub>	363	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{ heta JC}$	1.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	37	

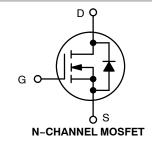
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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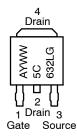
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
60 V	2.5 mΩ @ 10 V	155 ^
	3.4 mΩ @ 4.5 V	155 A





DPAK CASE 369C STYLE 2

# MARKING DIAGRAM & PIN ASSIGNMENT



A = Assembly Location

Y = Year
WW = Work Week
5C632L = Device Code
G = Pb-Free Package

# **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				-	-	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub>	= 250 μΑ	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				24		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 60 V	T <sub>J</sub> = 25°C			10	μΑ
			T <sub>J</sub> = 125°C			250	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.2		2.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.8		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 50 A			2.1	2.5	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 50 A			2.7	3.4	1
Forward Transconductance	9FS	$V_{DS} = 3 \text{ V}, I_{D}$	= 50 A		185		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCES						
Input Capacitance	C <sub>iss</sub>				5700		pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 25 \text{ V}$			2800		1
Reverse Transfer Capacitance	C <sub>rss</sub>				36		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>DS</sub> = 48 V,	V <sub>GS</sub> = 4.5 V		34		nC
		$I_D = 50 \text{ A}$	V <sub>GS</sub> = 10 V		78		1
Total Gate Charge	Q <sub>G(TOT)</sub>		•		34.0		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 48 V, I <sub>D</sub> = 50 A			9.5		1
Gate-to-Source Charge	Q <sub>GS</sub>				16.8		1
Gate-to-Drain Charge	$Q_{GD}$	. <sub>D</sub> = 33	^`		6.1		1
Plateau Voltage	V <sub>GP</sub>				3.1		V
Gate Resistance	$R_{G}$				0.7		Ω
SWITCHING CHARACTERISTICS (Note 5)						•	
Turn-On Delay Time	$t_{d(on)}$				20		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{I}$	ne = 48 V.		126		1
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 50 \text{ A}, R_G = 2.5 \Omega$			65		1
Fall Time	t <sub>f</sub>				121		1
DRAIN-SOURCE DIODE CHARACTERISTIC	s		•				
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 50 A	T <sub>J</sub> = 25°C		0.8	1.2	V
			T <sub>J</sub> = 125°C		0.7		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 50 A			71		ns
Charge Time	ta				36		1
Discharge Time	tb				36		1
Reverse Recovery Charge	Q <sub>RR</sub>				110		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

# **TYPICAL CHARACTERISTICS**

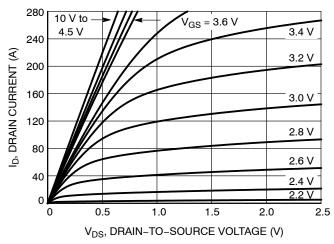
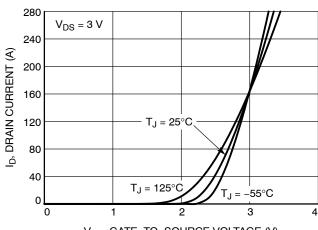


Figure 1. On-Region Characteristics



V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

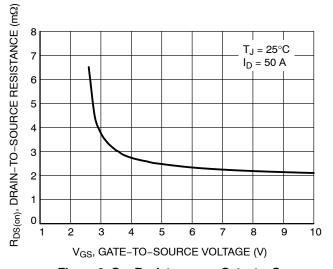


Figure 3. On-Resistance vs. Gate-to-Source Voltage

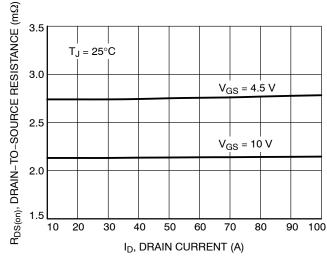


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

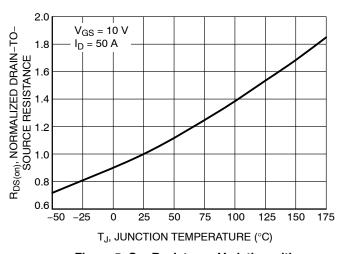


Figure 5. On–Resistance Variation with Temperature

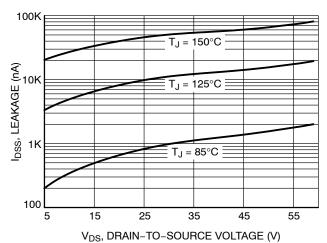


Figure 6. Drain-to-Source Leakage Current vs. Voltage

# **TYPICAL CHARACTERISTICS**

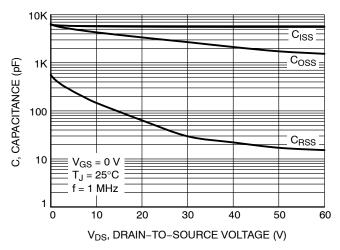


Figure 7. Capacitance Variation

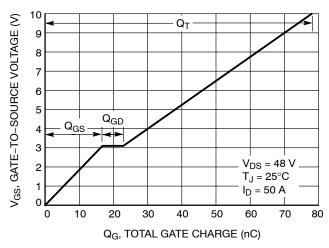


Figure 8. Gate-to-Source Voltage vs. Total Charge

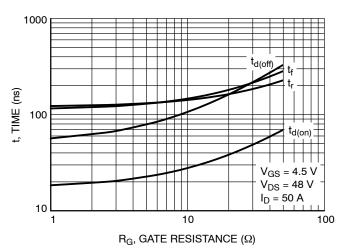


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

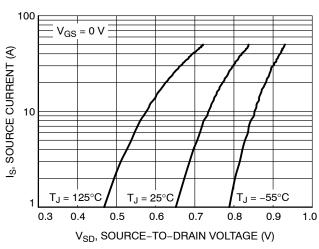


Figure 10. Diode Forward Voltage vs. Current

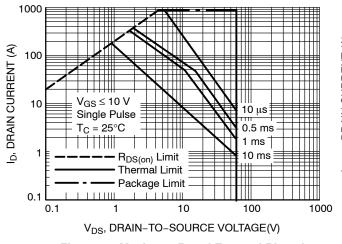


Figure 11. Maximum Rated Forward Biased Safe Operating Area

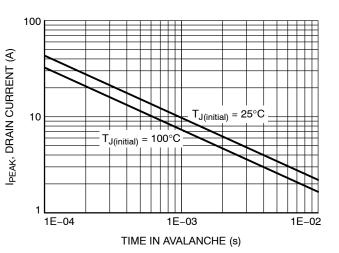


Figure 12. Maximum Drain Current vs. Time in Avalanche

# **TYPICAL CHARACTERISTICS**

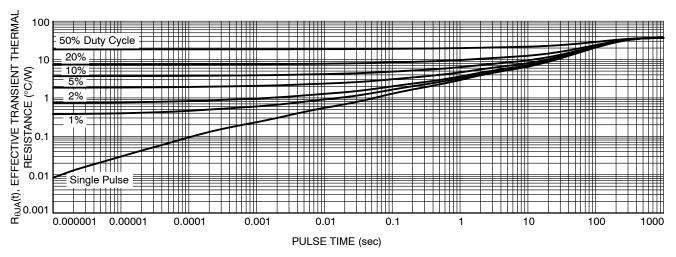


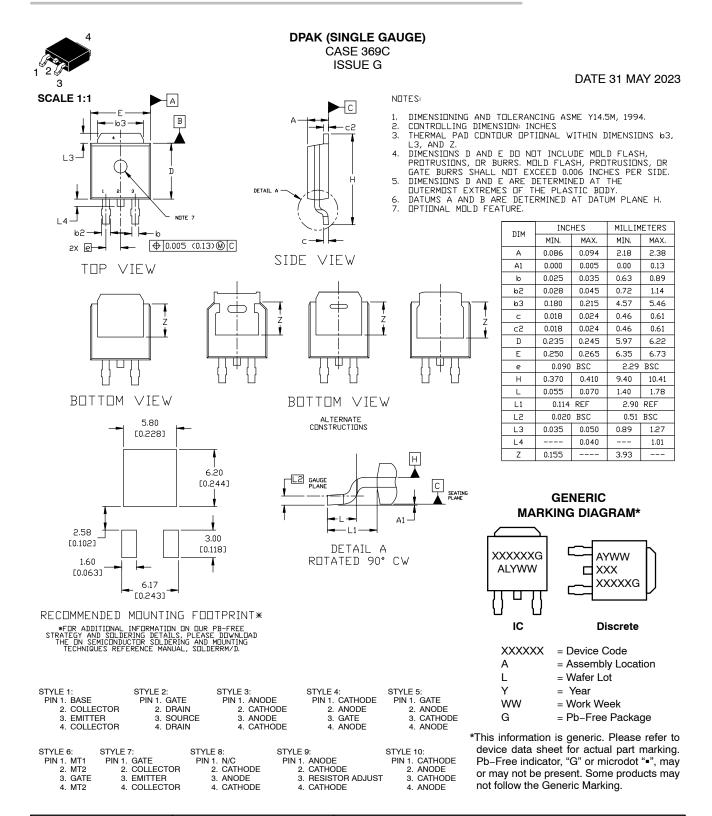
Figure 13. Thermal Response

# **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NVD5C632NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





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